

The electrode membranes were prepared by a previously-reported method,¹⁾ and contained PVC(27.6 wt%), the neutral carrier(2.8 wt%), DOP(dioctyl phthalate)(69.1 wt%), and dipicrylamine sodium salt(0.5 wt%). After injecting 1 M(1 M=1 mol·dm⁻³) KNO₃ aqueous solution as the internal filling solution, the electrodes were conditioned by soaking them in 10⁻³ M AgNO₃ for 3 days. The electrochemical cell

for the e.m.f. measurements was as follows: Ag-AgCl/4 M KCl/0.1 M NH_4NO_3 / sample solution/membrane/1 M KNO_3 /AgCl-Ag

A typical e.m.f. response of the 1-based ion-selective electrode to Ag^+ is shown in Fig. 1. An ideal Nernstian slope (59 mV/decade) for Ag^+ was attained in the Ag^+ activity range of 10^{-5} — 10^{-2} M. The response time of the 1-based Ag^+ -selective electrode was within 30 s. The electrode properties were hardly changed for at least 3 months. The high selectivity and durability of the electrode might be attributed partly to the high lipophilicity of the thiacycrown ether. Thus, the Ag^+ -selective electrode based on 1 is quite promising for practical applications. Figure 2 gives the Ag^+ selectivities of the electrode against other heavy metal ions, alkali and alkaline-earth metal ions, and NH_4^+ . The interference by the metal ions except Hg^{2+} is negligible. Even the Ag^+ selectivity against Hg^{2+} ($k_{\text{AgHg}}^{\text{Pot}} = 1.6 \times 10^{-2}$) was drastically improved as compared to that ($k_{\text{AgHg}}^{\text{Pot}} = 0.77$) of the previous thiacycrown ether-based electrodes.⁴⁾ Furthermore, the 1-based Ag^+ -selective electrode is definitely superior to popular Ag_2S -based Ag^+ electrodes in the Hg^{2+} interference, since coexistence of Hg^{2+} in measuring solutions never be allowed in the Ag_2S -based electrode system. Further study is currently under way.

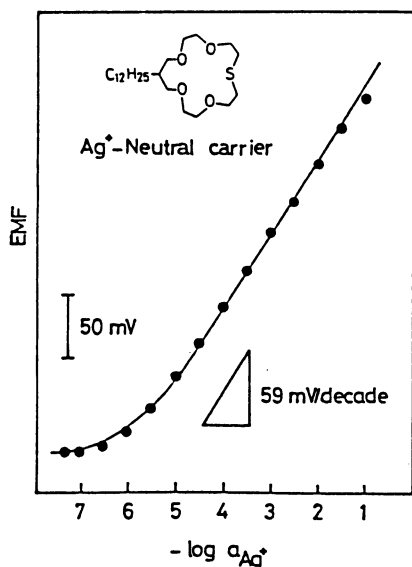


Fig. 1. Calibration plots for Ag^+ -selective electrode based on 1. (left)

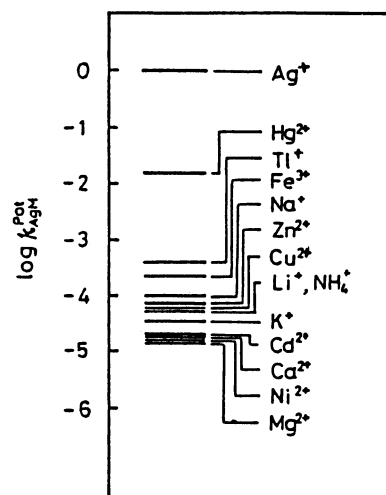


Fig. 2. Selectivity coefficients $\log k_{\text{AgM}}^{\text{Pot}}$. (Determined by FIM) (right)

References

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